TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π-MOSV)

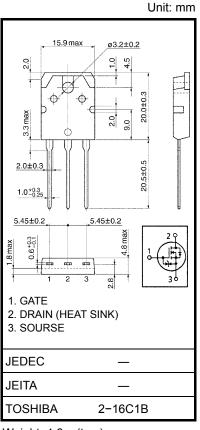
# 2SK2744

Chopper Regulator, DC-DC Converter and Motor Drive Applications

- 4-V gate drive
- Low drain-source ON resistance:  $R_{DS}$  (ON) = 15 m $\Omega$  (typ.)
- High forward transfer admittance:  $|Y_{fs}| = 27 \text{ S (typ.)}$
- Low leakage current:  $IDSS = 100 \mu A (max) (VDS = 50 V)$
- Enhancement mode:  $V_{th} = 1.5 \sim 3.5 \text{ V} (V_{DS} = 10 \text{ V}, I_D = 1 \text{ mA})$

### Absolute Maximum Ratings (Ta = 25°C)

| Characteristics         |                       | Symbol           | Rating  | Unit |  |
|-------------------------|-----------------------|------------------|---------|------|--|
| Drain-source voltage    |                       | V <sub>DSS</sub> | 50      | V    |  |
| Drain-gate voltage (RG  | <sub>S</sub> = 20 kΩ) | V <sub>DGR</sub> | 50      | V    |  |
| Gate-source voltage     |                       | V <sub>GSS</sub> | ±20     | V    |  |
| Drain current           | DC (Note 1)           | ۱ <sub>D</sub>   | 45      | А    |  |
|                         | Pulse (Note 1)        | I <sub>DP</sub>  | 180     | A    |  |
| Drain power dissipation | n (Tc = 25°C)         | PD               | 125     | W    |  |
| Single pulse avalanche  | e energy<br>(Note 2)  | E <sub>AS</sub>  | 95      | mJ   |  |
| Avalanche current       |                       | I <sub>AR</sub>  | 45      | А    |  |
| Repetitive avalanche e  | nergy (Note 3)        | E <sub>AR</sub>  | 12.5    | mJ   |  |
| Channel temperature     |                       | T <sub>ch</sub>  | 150     | °C   |  |
| Storage temperature ra  | ange                  | T <sub>stg</sub> | -55~150 | °C   |  |



Weight: 4.6 g (typ.)

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc.).

### **Thermal Characteristics**

| Characteristics                        | Symbol                 | Max | Unit |
|--|------------------------|-----|------|
| Thermal resistance, channel to case    | R <sub>th (ch-c)</sub> | 1.0 | °C/W |
| Thermal resistance, channel to ambient | R <sub>th (ch-a)</sub> | 50  | °C/W |

Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2:  $V_{DD} = 25 \text{ V}, \text{ T}_{ch} = 25^{\circ}\text{C}$  (initial), L = 58  $\mu$ H, R<sub>G</sub> = 25  $\Omega$ , I<sub>AR</sub> = 45 A

Note 3: Repetitive rating: pulse width limited by maximum junction temperature

This transistor is an electrostatic-sensitive device. Please handle with caution.

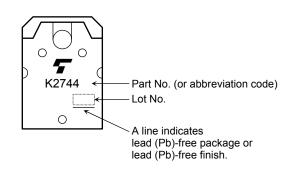
**Electrical Characteristics (Ta = 25°C)** 

| Chara  | acteristics   | Symbol               | Test Condition   | Min | Тур. | Max | Unit |
|--|---------------|----------------------|--|-----|------|-----|------|
| Gate leakage cur                                   | rrent         | I <sub>GSS</sub>     | $V_{GS} = \pm 16$ V, $V_{DS} = 0$ V  | _   | —    | ±10 | μA   |
| Drain cut-off current                              |               | I <sub>DSS</sub>     | $V_{DS} = 50 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$  | _   | _    | 100 | μA   |
| Drain-source breakdown voltage                     |               | V (BR) DSS           | $I_D = 10 \text{ mA}, V_{GS} = 0 \text{ V}$  | 50  | _    | _   | V    |
| Gate threshold ve                                  | oltage        | V <sub>th</sub>      | $V_{DS} = 10 \text{ V}, \text{ I}_{D} = 1 \text{ mA}$  | 1.5 | _    | 3.5 | V    |
| Drain-source ON                                    | resistance    | R <sub>DS (ON)</sub> | $V_{GS} = 10 \text{ V}, \text{ I}_{D} = 25 \text{ A}$  |     | 15   | 20  | mΩ   |
| Forward transfer                                   | admittance    | Y <sub>fs</sub>      | $V_{DS} = 10 \text{ V}, \text{ I}_{D} = 25 \text{ A}$  | 15  | 27   | _   | S    |
| Input capacitance                                  |               | C <sub>iss</sub>     | $V_{DS} = 10 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ f} = 1 \text{ MHz}$   |     | 2300 | _   | pF   |
| Reverse transfer capacitance                       |               | C <sub>rss</sub>     |  |     | 420  |     | pF   |
| Output capacitance                                 |               | C <sub>oss</sub>     |  |     | 1200 |     | pF   |
| Switching time                                     | Rise time     | tr                   | $U_{GS} = 25 \text{ A}$ $U_{GS} = 25 \text{ A}$ $U_{GS} = 0 \text{ V}$ $U_{G} = 0 \text{ V}$ $U_{G} = 0 \text{ V}$ $U_{DD} = 25 \text{ V}$ $U_{DD} = 25 \text{ V}$ $U_{DU} = 10  \mu\text{ s}$ |     | 30   | _   |      |
|  | Turn-on time  | t <sub>on</sub>      |  | _   | 45   | _   | 20   |
|  | Fall time     | t <sub>f</sub>       |  |     | 80   |     | ns   |
|  | Turn-off time | t <sub>off</sub>     |  | _   | 230  |     |      |
| Total gate charge<br>(gate-source plus gate-drain) |               | Qg                   | $V_{DD} \simeq 40$ V, $V_{GS} = 10$ V, $I_D = 45$ A  | —   | 68   | _   | nC   |
| Gate-source charge                                 |               | Q <sub>gs</sub>      |  |     | 20   |     | nC   |
| Gate-drain ("miller") charge                       |               | Q <sub>gd</sub>      |  |     | 48   |     | nC   |

# Source-Drain Ratings and Characteristics (Ta = 25°C)

| Characteristics                              | Symbol           | Test Condition  | Min | Тур. | Max  | Unit |
|--|------------------|---|-----|------|------|------|
| Continuous drain reverse current<br>(Note 1) | I <sub>DR</sub>  | _   | _   | _    | 45   | A    |
| Pulse drain reverse current<br>(Note 1)      | I <sub>DRP</sub> | _   | _   | _    | 180  | А    |
| Forward voltage (diode)                      | V <sub>DSF</sub> | $I_{DR} = 45 \text{ A}, \text{ V}_{GS} = 0 \text{ V}$ |     |      | -1.8 | V    |
| Reverse recovery time                        | t <sub>rr</sub>  | $I_{DR} = 45 \text{ A}, \text{ V}_{GS} = 0 \text{ V}$ | _   | 130  | _    | ns   |
| Reverse recovery charge                      | Q <sub>rr</sub>  | dI <sub>DR</sub> /dt = 50 A/µs                        | _   | 0.3  | _    | μC   |

## Marking



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